

## 36V Precision, 2.5 nV/√Hz, Rail-to-Rail Output Amplifier

# **Preliminary Technical Data**

# AD8675

## FEATURES

Very Low Voltage Noise 2.5nV/√Hz Rail-to-Rail Output Swing Low Input Bias Current: 5 nA Max Very Low Offset Voltage: 50 µV Max Low Input Offset Drift: 0.6 µV/°C Max Very High Gain: 120 dB Wide Bandwidth: 10MHz ±5V to ±15V Operation

### APPLICATIONS

Precision Instrumentation PLL Filters Laser Diode Control Loops Strain Gage Amplifiers Medical Instrumentation Thermocouple Amplifiers

### **GENERAL DESCRIPTION**

This new precision amplifier has ultra-low offset, drift and voltage noise combined with very low input bias currents over the full operating temperature range. The AD8675 is a precision, wide bandwidth amplifier featuring rail-to-rail output swings and very low noise. Operation is fully specified from  $\pm$ 5V to  $\pm$ 15 volts.

The AD8675 combines the R-R output of the OP184 with wide bandwidth and even lower voltage noise and with the precision and low power consumption of the industry-standard OP07 amplifier. Unlike other low noise R-R amplifiers the AD8675 has very low input bias current and low input current noise.

With an offset voltage of only  $20\mu$ V, offset drift of  $0.2 \mu$ V/°C and noise of only 0.25uV P-P (0.1Hz to 10 Hz) the AD8675 is perfectly suited for applications where large error sources cannot be tolerated. For applications with even lower offset tolerances, the proprietary nulling capability allows a combination of both device and system offset errors up to 1mV(referred to the input) to be compensated externally. Unlike previous circuits, the AD8675 accommodates this adjustment without adversely affecting the offset drift, CMRR and PSRR of the amplifier. Precision Instrumentation, PLL and other precision filter circuits, position and pressure sensors, medical instrumentation, and strain gage amplifiers benefit greatly from

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the very low noise, low input bias current and wide bandwidth. Many systems may take advantage of the low noise, DC precision and rail-to-rail output swing provided by the AD8675 to maximize SNR and dynamic range.

The smaller packages and low power consumption afforded by the AD8675 allow maximum channel density or minimum board size for space-critical equipment.

The AD8675 is specified for the extended industrial  $(-40^{\circ} \text{ to } +125^{\circ}\text{C})$  temperature range. The AD8675 amplifier is available in the tiny MSOP-8 and the popular 8-pin narrow SOIC lead-free packages. MSOP packaged devices are only available in Tape-and-Reel format.

8-Lead S (	OIC/8-Lea R-8/RM-8	
NULL 1 -IN 2 +IN 3 V- 4	AD8675	8 NULL 7 V+ 6 OUT 5 NC
N	C = NO CONN	NECT

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#### $ELECTRICAL SPECIFICATIONS (v_{S} \pm 5.0V, v_{CM} = 0V, v_{O} = 0V, v_{O} = 0V, v_{A} = +25^{\circ}C \text{ unless otherwise specified.})$ Conditions Symbol Min Parameter Тур Max Units INPUT CHARACTERISTICS Offset Voltage VOS 20 50 μV Input Bias Current 2 I<sub>B</sub> 5 nA $-40^\circ C \leq T_A \leq +125^\circ C$ 3 6 nA Input Offset Current $\mathbf{I}_{\text{OS}}$ 0.5 1 nA $-40^\circ C \leq T_A \leq +125^\circ C$ 2 nA 3.5 Input Voltage Range -3.5 V Common-Mode Rejection Ratio CMRR $V_{CM} = -3.5V$ to 3.5V 110 dB 120 $-40^{\circ}C \le T_A \le +125^{\circ}C$ 105 dB 115 Open Loop Gain (Note 1) $R_L = 2 k\Omega$ to Ground, 120 dB Avo Vo=-4.0V to 4.0V $-40^\circ C \leq T_A \leq +125^\circ C$ 120 dB Offset Voltage Drift $\Delta V_{OS} / \Delta T$ $-40^{\circ}C \le T_A \le +125^{\circ}C$ 0.2 0.6 $\mu V/^{\circ}C$ OUTPUT CHARACTERISTICS $R_L = 2k\Omega$ to Ground 4.9 4.92 Output Voltage High VOH V $-40^{\circ}C \le T_A \le +125^{\circ}C$ V 4.8 4.85 $R_L = 600\Omega$ to Ground 4.5 v 4.55 $-40^{\circ}C \leq T_A \leq +125^{\circ}C$ 4.4 4.45 V v $R_L = 2k\Omega$ to Ground -4.92 -4.9 Output Voltage Low VOL $-40^\circ C \leq T_A \leq +125^\circ C$ -4.85 -4.8 V $R_L = 600\Omega$ to Ground -4.55 -4.5 V $-40^\circ C \leq T_A \leq +125^\circ C$ -4.45 4.4 v Short Circuit Limit 40 mA I<sub>SC</sub> $-40^\circ C \leq T_A \leq +125^\circ C$ 30 mΑ Output Current $I_O$ $\pm 20$ mА $-40^{\circ}C \leq T_A \leq +125^{\circ}C$ $\pm 15$ mA POWER SUPPLY PSRR $V_{S} = = \pm 5.0 V$ to $\pm 15.0 V$ Power Supply Rejection Ratio 100 110 dB $-40^{\circ}C \le T_A \le +125^{\circ}C$ dB 100 110 Supply Current/Amplifier $V_0 = 0V$ 2.5 ISY 3 mA $-40^\circ C \leq T_A \leq +125^\circ C$ 3.2 mA DYNAMIC PERFORMANCE Slew Rate SR $R_L = 2 k\Omega$ 1 V/µs GBP MHz Gain Bandwidth Product 10 NOISE PERFORMANCE Voltage Noise 0.1 to 10 Hz 0.1 $\mu V_{p-p}$ enp-p Voltage Noise Density nV/√Hz e<sub>n</sub> f = 1 kHz2.5 Current Noise Density pA/√Hz in f =10 Hz 0.3

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# **ELECTRICAL SPECIFICATIONS** $(V_S = \pm 15V, V_{CM} = 0V, V_O = 0V, T_A = \pm 25^{\circ}C$ unless otherwise specified.)

Parameter	Symbol	Conditions	Min	Тур	Max	Units
INPUT CHARACTERISTICS						
Offset Voltage	V <sub>OS</sub>			20	50	μV
Input Bias Current	IB			2.5	5	nA
		$-40^{\circ}C \leq T_A \leq +125^{\circ}C$		3	6	nA
Input Offset Current	I <sub>OS</sub>			50	1	nA
		$-40^{\circ}C \le T_A \le +125^{\circ}C$			2	nA
Input Voltage Range			-13.5		13.5	V
Common-Mode Rejection Ratio	CMRR	$V_{CM} = -12.5V$ to 12.5V	110	120		dB
		$-40^{\circ}C \le T_A \le +125^{\circ}C$	105	110		dB
Open Loop Gain	A <sub>VO</sub>	$R_L = 2k\Omega$ to Ground,	120			dB
		Vo=-14.0V to 14.0V				
		$-40^{\circ}C \le T_A \le +125^{\circ}C$	120			dB
Offset Voltage Drift	$\Delta V_{OS} / \Delta T$	$-40^{\circ}C \leq T_A \leq +125^{\circ}C$		0.2	0.6	μV/°C
OUTPUT CHARACTERISTICS						
Output Voltage High	V <sub>OH</sub>	$R_L = 2k\Omega$ to Ground	14.9	14.95		V
		$-40^{\circ}C \le T_A \le +125^{\circ}C$	14.8	14.85		V
		$R_{\rm L} = 600\Omega$ to Ground	14.5	14.55		v
		$-40^{\circ}C \le T_A \le +125^{\circ}C$	14.4	14.45		v
Output Voltage Low	V <sub>OL</sub>	$R_L = 2k\Omega$ to Ground		-14.95	-14.9	V
	- OL	$-40^{\circ}C \le T_A \le +125^{\circ}C$		-14.85	-14.8	V
		$R_L = 600\Omega$ to Ground		-14.55	-14.5	V
		$-40^{\circ}C \le T_A \le +125^{\circ}C$		-14.45	-14.4	v
Short Circuit Limit	I	$-40 C \le 1_A \le +125 C$		40	-14.4	mA
Short Circuit Linit	I <sub>SC</sub>	$40^{\circ}C < T < 125^{\circ}C$		30		
Output Current	T	$-40^{\circ}C \le T_A \le +125^{\circ}C$				mA m A
Output Current	IO	40°C < T < 125°C		± 20		mA
		$-40^{\circ}C \le T_A \le +125^{\circ}C$		± 15		mA
POWER SUPPLY Power Supply Rejection Ratio	PSRR	$V_{+50V}$ to +150V	100	110		dB
Tower Suppry Rejection Ratio	FORK	$V_{\rm S} = =\pm 5.0$ V to $\pm 15.0$ V				
Secondary Comment/Act	<b>T</b>	$-40^{\circ}C \le T_A \le +125^{\circ}C$	100	110		dB
Supply Current/Amplifier	I <sub>SY</sub>	$V_{\rm O} = 0V$		2.5	3	mA
		$-40^{\circ}C \le T_A \le +125^{\circ}C$			3.2	mA
DYNAMIC PERFORMANCE		D 1010				
Slew Rate	SR	$R_L = 10 \text{ k}\Omega$		1		V/µs
Gain Bandwidth Product	GBP			10		MHz
NOISE PERFORMANCE		0.1 to 10 Uz		0.1		
Voltage Noise	e <sub>n p-p</sub>	0.1 to 10 Hz		0.1		$\mu V_{p-p}$
Voltage Noise Density	e <sub>n</sub>	f = 1  kHz		2.5		nV/√Hz
Current Noise Density	in	f = 10 Hz		0.3		pA/√Hz

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### ABSOLUTE MAXIMUM RATINGS

Supply Voltage	±18V
Input Voltage	±Vsupply
Differential Input Voltage	±0.7V
Output Short-Circuit Duration to Gnd	Indefinite
Storage Temperature Range	
RM, R Package	
Operating Temperature Range	
AD8675	-40°C to +125°C
Junction Temperature Range	
RM, R Package	$-65^{\circ}C$ to $+150^{\circ}C$
Lead Temperature Range (Soldering, 10 sec).	+300°C

Package Type	$\theta_{JA}{}^1$	θJC	Units
8-Pin MSOP (RM)	210	45	°C/W
8-Pin SOIC (R)	158	43	°C/W

### NOTES

 $^{1}$   $\theta_{JA}$  is specified for the worst case conditions, i.e.,  $\theta_{JA}$  is specified for device in socket for P-DIP packages;  $\theta_{JA}$  is specified for device soldered in circuit board for SOIC and TSSOP packages.

### **ORDERING GUIDE**

Model	Temperature	Package	Package
	Range	Description	Option
AD8675ARMZ	-40°C to +125°C		RM-8
AD8675ARZ	-40°C to +125°C		R-8

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those listed in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.